## NATIONAL RADIO ASTRONOMY OBSERVATORY CHARLOTTESVILLE, VIRGINIA

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# 15 GHz COOLED GAASFET AMPLIFIER - DESIGN BACKGROUND INFORMATION

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#### NATIONAL RADIO ASTRONOMY OBSERVATORY Charlottesville, Virginia

#### 15 GHz COOLED GaAsFET AMPLIFIER -

#### DESIGN BACKGROUND INFORMATION

#### Manuel Sierra

I. Noise Parameters of FET's

#### Measurement and Analysis Procedure

In order to obtain the noise parameters of FET's used in a 3-stage amplifier, a one stage amplifier has been constructed and the noise measured for a set of five source impedances and five values for the bias current.

The input and output networks have been made with a  $\lambda/4$  sliding transformer over a 50 ohm transmission line, as shown in Figure 1. With this mount, it is easy to change the source impedance by changing the diameter of the  $\lambda/4$  transformer or the dielectric surrounding it, which changes the absolute value of the reflection coefficient, or by moving this transformer along the 50 ohm line, which changes the phase. Nevertheless, for the noise parameter measurements, the transformer position has been selected to get a minimum noise at the design frequency (14.9 GHz) for each transformer impedance.

Usually, the amplifier input is tuned for minimum noise at only one bias and at room temperature, and some frequency variations in the minimum noise can be expected. Taking this minimum, that must happen not too far from the design frequency, it is assumed that at that point the source reactance is optimum  $(X_s = X_{opt})$ , and the noise parameters not too far from those at the design frequency. When three or more source impedances have been tried, is is possible to determine the three noise parameters by adjusting the theoretical parabolic



function. This has been done with the aid of the computer program "Ropt 1" discussed in Appendix 1. The program adjusts the values of  $R_{opt}$ ,  $T_{min}$  and  $G_n$  for the least quadratic error method and presents the final values as well as the mean square error on temperature.

For all these measurements, the output network is matched for maximum return loss; this allows high gain and, hence, lower errors in the second stage noise cancellation.

#### Noise Parameters for NE-137 and MGF-1412

Measuring the NE-137 FET, five transformers have been used, with 10, 12, 22, 26 and 36 ohm characteristic impedance. We also took the noise corresponding to five different bias currents, from 3 to 15 mA and the drain voltage that leads to a minimum noise at each current. For the NE-137, the drain voltage does not affect the noise, at least between 2.5 and 5 volts, and the small variations for low current have a minimum noise around 3 or 4 volts. It is important to note that the output match is more affected by the drain voltage, and that also affects the second stage noise. This means that the optimum voltage in noise measurements usually remains the same as the one selected for the output tuning.

The final results for the packaged NE-137 at 15K and room temperature are shown in Figure 2, where the noise temperature is plotted versus the source resistance, using the drain current as a parameter. It can be seen that at room temperature, the optimum current is around 5 mA and  $R_{opt} \simeq 4$  ohms. At 15K the optimum current drops to values under 3 mA and the optimum source resistance to under 2 ohms, but taking into account that the gain also drops very fast for low currents, the optimum noise measure occurs around 3 mA.

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The table gives the noise parameters Noise temperature at 300K (left) and 15K (right) for NE13783 as function of generator resistance and drain current. determined from the figure. Fig. 2.

The drain voltage has little effect upon the noise, and usually is selected in order to have the best output match or to optimize the second stage noise when using more than a one-stage amplifier.

From the MGF-1412 measurements, the same temperature dependence can be seen in the noise parameters and in the optimum bias current. The most important difference between this and the NE-137 is the greater drain voltage dependence of the MGF-1412 noise; an optimum voltage can be clearly found for each drain current. Usually the optimum voltage increases as the current increases, keeping the gate voltage fairly constant except for very low currents.

It looks like the noise parameters of the MGF-1412's are related to both drain current and gate voltage through two independent functions, at least in the most important range of bias.

The optimum source reactance has been estimated from circuit modeling and assumed constant; the frequency where the minimum noise appears changes only a small amount when the bias or physical temperatures are changed.

The MGF-1412 measurements are shown in Figure 3 with values at 15K and room temperature.

In Appendix 2 are presented the circuit and noise parameter models used in the computer programs for these two FET's. The frequency variation of the noise parameters has also been estimated from the frequency behavior of chip noise predicted by Pucel.

#### Errors in the Noise Measurements

Due to the low gain of these transistors at 15 GHz, large errors can be expected in one-stage amplifier measurements if all additional noise contributions are not taken into account.

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Noise temperature at 300K (left) and 15K (right) for MGF-1412 as function The table gives the noise of generator resistance and drain current. parameters determined from the figure. Fig. 3.

We are going to analyze here only the errors due to the noise source calibration and the second-stage noise cancellation, assuming that the rest has little influence in the final error.

In order to avoid changes in the noise source impedance when switching, and also to get a lower off temperature, a 20 dB cooled pad is used following the noise source. The total losses from the noise source to the amplifier input have been measured and the equivalent off and on temperatures are computed.

Assuming that the noise diode calibration has no errors, the error due to the pad attenuation can be computed as follows:

$$\frac{\Delta T}{\Delta \alpha} \sim .25 (T + T_{off}) K/dB$$
 (1)

where T is the measured temperature and  $\Delta \alpha$  is the attenuation error in dB (<1). T<sub>off</sub> is the equivalent off temperature.

Another noise contribution came from the receiver or second stage. This additional noise is taken into account measuring the second stage noise and computing its contribution to the total noise. In fact, measuring first the equivalent noise and gain of the receiver  $(T_R, G_R)$  and then the total noise and gain  $(T_T, G_T)$ , the receiver noise contribution is done by

$$T_{e} = \frac{T_{R}}{G_{av}} = T_{R} \cdot \frac{G_{R}}{G_{T}}$$
(2)

where  $G_{av}$  is the available gain of the amplifier. In equation (2), it is assumed that the receiver performance (noise and gain) remains the same when driven by the noise source and when driven by the amplifier.

The difference between the reflection coefficient of the noise source and the amplifier output causes an error in the receiver performance. Let us assume, as shown in Figure 4, that the receiver is driven by a circulator with input reflection coefficient  $\Gamma_R$  and physical temperature  $T_c$ . The error in the receiver noise contribution can be written as follows (see Appendix 3):

$$\Delta T = \frac{T_{c}(|\Gamma_{2}|^{2} - |\Gamma_{s}|^{2})}{G_{m}} \cdot \left| \frac{1 - \Gamma_{s}\Gamma_{R}}{1 - \Gamma_{2}\Gamma_{R}} \right|^{2} - \frac{T_{R}}{G_{m}} \left( 1 - \left| \frac{1 - \Gamma_{s}\Gamma_{R}}{1 - \Gamma_{2}\Gamma_{R}} \right|^{2} \right)$$

where  $G_m$  is the measured gain  $G_m = G_T/G_R$  and the reflection coefficients are defined as shown in Figure 4.

The noise source is usually well matched and then the first term is positive and is the noise generated in the circulator load and reflected in the amplifier output. The second term depends on the relative phases of the reflection coefficients and can be either positive or negative. The extreme values for this error when  $\Gamma_s \simeq 0$  can be written as follows:

$$\Delta T_{\text{max}} \simeq \frac{T_c |\Gamma_2|^2 + T_R(2|\Gamma_2\Gamma_R|)}{G_m(1 + |\Gamma_2\Gamma_R|)^2}$$
$$\Delta T_{\text{min}} \simeq \frac{T_c |\Gamma_2|^2 - T_R(2|\Gamma_2\Gamma_R|)}{G_m(1 + |\Gamma_2\Gamma_R|)^2}$$

In order to minimize these errors, the amplifier output has been matched at least with 15 dB return loss and a cooled circulator as well as the receiver input circulator have been used.



Fig. 4. Test set for computer measurement of amplifier gain and noise temperature. Top configuration is for "CAL" mode which determines receiver gain and noise temperature; lower configuration is for "TEST" mode which determines amplifier gain and noise temperature.



Fig. 5. Test setup for measurement of cryogenically cooled amplifier.

The final mount for cooled measurements is shown in Figure 5 where most parameters are specified. The final error limits are listed in Table 1.

#### TABLE I. Measurement Errors

Physical Temperature	300	<u>)K</u>	15	<u>5K</u>
Noise source NDB	-5.58	<u>+</u> .05	5.56	<u>+</u> .1
Noise source error	<u>&lt;</u> 1	ОК	<u>&lt;</u> 2.	4K
Amplifier gain	> 4dB	> 7dB	> 5dB	> 8dB
Cooled isolator noise	+ 3.8	+ 1.9	+ .15	+ .06
Second isolator noise			+ 3.8	+ 9.5
Second stage noise error	<u>+</u> 10.2	<u>+</u> 5.1	<u>+</u> 14.6	<u>+</u> 5.8

#### Package and Chip Noise Parameters

Having a model for the FET package, it is possible to compute the chip noise parameters and see how they agree with the theoretical predictions or other frequency measurements.

The package model has been computed for the MGF-1412 from S parameters and low frequency package measurements as discussed in [1]. The NE-137 package model has been computed from the chip and packaged FET S-parameters.

The models are shown in Appendix 2. The chip noise parameters for the NE-137 and MGF-1412 are also shown in Table II. Two bias currents are used to compute these parameters, the recommended and the minimum noise current, both at 15K and at room temperature.

<u>NE-137</u>	30	300K		15К	
Bias	10 mA, 3V	5 mA, 3V	10 mA, 3V	3 mA, 3V	
T <sub>min</sub>	182	164	34.1	21.3	
R <sub>opt</sub>	6.6	4.9	3.4	1.23	
X <sub>opt</sub>	27.3	27.6	27.4	27.5	
G <sub>n</sub> (mmhos)	26.5	35.7	8.2	12.1	

300K		15K

TABLE II. Chip Noise Parameters

<u>MGF-1412</u>	300К		15K		
Bias	10 mA, 5.5 V	5 mA, 4V	10 mA, 5V	3 mA, 3.5V	
T <sub>min</sub>	289	267	49.2	28.3	
R <sub>opt</sub>	12.5	10.8	8.7	3.5	
X <sub>opt</sub>	16.3	19.2	18.9	22.3	
G <sub>n</sub> (mmhos)	20.8	26.4	6.3	6.2	

From the chip noise parameters and assuming the theoretical frequency variation, it is possible to compute the noise parameter frequency dependence of the packaged FET. This has been done in Figures 6-13 for both transistors at room temperature and cooled. It is interesting to note that noise parameters of the packaged transistors are much different from those of the chip at high frequencies. The noise temperature is not affected by the package input circuit but is affected by the source inductance in such a way that the noise measure remains constant.

Looking at these figures, it is reasonable that it is not possible to compare the noise parameters at different frequencies if the mount or surrounding



Fig. 6. Optimum source impedance at 300K for the NE137 in steps of 1 GHz from 1 to 18 GHz.



Fig. 8. Optimum source impedance at 15K for the NE137 in steps of 1 GHz from 1 to 18 GHz.



Fig. 7. Noise parameters,  ${\rm T_{min}}$  and  ${\rm g}_{\rm n},$  for the NE137 at 300K in the 1 to 18 GHz frequency range.



Fig. 9. Noise parameters,  $T_{\mbox{min}}$  and  $g_{\mbox{n}}$  , for the NE137 at 15K in the 1 to 18 GHz frequency range.



Fig. 10. Optimum source impedance at 300K for the MGF-1412 in steps of 1 GHz from 1 to 18 GHz.



Fig. 12. Optimum source impedance at 15K for MGF-1412 in steps of 1 GHz from 1 to 18 GHz.



Fig. 11. Noise parameters,  $T_{min}$  and  $g_n$ , at 300K for the MGF-1412 in the 1 to 18 GHz frequency range.



Fig. 13. Noise parameters,  $\rm T_{min}$  and  $\rm g_n$ , for the MGF-1412 at 15K in the 1 to 18 GHz frequency range.

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circuit where the transistor has been measured are not the same. The only parameter that can be estimated is the noise measure that does not change with any reactive feedback.

#### II. Amplifier Design

#### **Technology**

The final amplifier has been realized with the same technology as the one-stage test mount previously described. The main transmission line is a coaxial line formed by the square outer conductor machined as a groove in the chassis, and a circular inner conductor supported by a .05 inch thick polystyrene support to prevent movement along the line [2].

The input and output network used for each stage is formed by a  $\lambda/4$  transmission line with a lower than 50 $\Omega$  characteristic impedance in cascade with a 50 $\Omega$  transmission line. With this coupling network, it is always possible to get any desired impedance.

The D.C. blocking capacitors are formed by inserting the FET leads into the coaxial inner conductor lined with #22-PTFE teflon tubing. This forms a series transmission line that has around 38 ohm characteristic impedance and 1.8 effective dielectric constant. The open-circuited end has around .04 pF fringing capacitance.

Although it is possible to match any desired impedance with the described network, the frequency response depends on the selected circuit, getting a narrower bandwidth as the 50 ohm transmission line becomes longer. In order to have the proper distance between the slug and the FET ( $L \le \lambda/16$ ), the series transmission line length has been adjusted. At 15 GHz the optimum generator reactance becomes capacitive because of the package inductive effects, and it is necessary to use shorter than  $\lambda/4$  series lines as D.C. blocking. D.C. bias is applied to the FET by  $\lambda/4$  wires from the chip bypass capacitors and a proper D.C. protecting circuit is used, as shown in Figure 14.

#### Design

A 14.4 to 15.4 GHz low-noise amplifier was required as a first stage for the front ends of the Very Large Array radio telescope. The unit must be optimized for minimum noise and have 20 dB gain with no more than 2 dB ripple over the band. An input match is not required since the input will be connected through a circulator.

From these specifications and previous one-stage measurements, it can be seen that at least three stages are required. The first and second stages are driven for minimum noise and the third one can be matched either for minimum noise or maximum gain depending on the final gain.

The first stage input network is then selected to have a minimum noise  $(Z_{opt})$ , and from the transistor parameters, it is possible to know the output impedance  $(Z_{out})$ . In order to have the optimum source impedance for the second stage, the inter-stage network must transform the first stage output impedance  $(Z_{out})$ to  $Z_{opt}$ . This condition provides two equations for computing the network, leaving one of the three parameters free (lossless network).

Going from  $Z_{out}$  to  $50\Omega$  and then to  $Z_{opt}$  as shown in Figure 14, the third parameter is easily identified with the 50-ohm transmission line length. This length can be selected in order to adjust the frequency performance or minimize the input reflection.

This solution is not the only one, of course. Any other solution can be good, but this one has the advantage that all parameters can be selected from one-stage measurements, and it is easy to mount and adjust.





In order to determine the length between transformers for maximum bandwidth and have a theoretical model for the amplifier performances, some computer programs have been developed, based on the transistor models and using FARANT subroutines [3].

At first two programs were developed to compute the optimum transformer impedance and inter-stage distances. The first one (Man #4) computes the interstage circuit to get a maximum input return loss at the design frequency. This condition also assures the maximum amplifier gain at the design frequency. It then computes the frequency response for a two-stage amplifier. Having a bad input match or at least not enough match to avoid isolators, we would rather select this third parameter to achieve the maximum bandwidth, doing this with a cut-and-try method aided by the Amp #1 program.

Finally, an analysis program was developed to allow final adjustment of the computer model before or at the same time as the experimental amplifier (Amp<sup>+</sup>#2).

The last two programs work with one, two or three stage amplifiers as desired. The programs are listed in Appendix 3.

#### Experimental Results

The three stage amplifier using the NE-137 as first stage and two MGF-1412's as second and third stages was built and optimized for minimum noise and flat gain in the band. The noise temperature and gain are shown in Figure 15 for both 300K and 15K operation. The optimum temperature around the design frequency is 40K and has an average temperature of 49K over a 1 GHz bandwidth. The gain is over 24 dB which allows a 4 dB output attenuator to match the amplifier to the following stage.

The amplifier is stable for any input and output load, but an isolator is necessary to improve the input match.

1) #112 WITH 15 OHM. INPUT TR. 0436.3 01/13/82 TAV=299.8 TL0=263.3 @ 14900 GL=16.7 GH=19.7 T=296.1K 4.98.5.2.-1.224 4.02.14.8.-.543 3.98.14.6.-1.239



1) #112 WITH 15 OHM. INPUT TR. 0659.7 01/13/82 TAV=65.8 TLO=55.2 @ 14800 GL=22.2 GH=24.3 T=10.9K 4.98,5.2,-1.923 4.02,14.9,-.463 4.01,14.6,-1.405

2) OPTIMUN BIAS 0709.7 01/13/82 TAV=48.6 TL0=40.6 @ 14800 GL=23.7 GH=25.7 T=11K 3.97,5.1,-1.745 5.51,14.8,-.58 5.5,19.5,-1.4



Fig. 15. Gain and noise temperature of amplifier #112 at 300K (top) and 20K (bottom) with 15 ohm input quarter-wave transformer. The 20K results are shown for first stage drain voltages of 5 volts and 4 volts (optimum).

#### REFERENCES

- [1] Sander Weinreb, "Low-Noise Cooled GASFET Amplifiers," <u>IEEE Trans. on</u> <u>Microwave Theory and Tech.</u>, vol. MTT-28, no. 10, October 1980.
- [2] G. Tomassetti, S. Weinreb, and K. Wellington, "Low-Noise 10.7 GHz Cooled GaAs FET Amplifier," <u>Electronics Letters</u>, vol. 17, no. 25/26, pp. 949-951, December 10, 1981.
- [3] D. L. Fenstermacher, "A Computer-Aided Analysis Routine Including Optimization for Microwave Circuits and Their Noise," NRAO Electronics Division Internal Report No. 217, July 1981.

#### Appendix I

Program "R<sub>opt</sub> 1" for HP-9845A Computer

#### Equations

This program computes the noise parameters (other than  $X_{opt}$ ) from a set of N measurements (N  $\geq$  3) by minimizing the mean square error between the calculated and measured noise temperatures. The function to be adjusted is:

$$T(R) = T_{min} + T_o G_n (R - R_{opt})^2 / R$$
 (1)

where  $T_o = 290K$  and  $T_{min}$ ,  $G_n$  and  $R_{opt}$  are unknowns. Having N points  $T_i$ ,  $R_i$  where i = 1 to N, the mean square error is:

$$E = \Sigma (T(R_i) - T_i)^2$$

and the rms error of the fit, in degrees Kelvin, is  $\sqrt{E/N}$ . The set of three equations that allows us to compute the noise parameters is:

$$\partial E / \partial T_{min} = 0$$
  
 $\partial E / \partial R_{opt} = 0$   
 $\partial E / \partial G_n = 0$ 

Letting  $\Delta t_i = T_{min} + T_o G_n (R_i - R_{opt})^2 / R_i - T_i$ , this set of equations can be interpreted as:

 $\Sigma \Delta t_{i} = 0$   $\Sigma \Delta t_{i} / R_{i} = 0$   $\Sigma \Delta t_{i} \cdot R_{i} = 0$ 

The unknowns can be extracted from these three equations and finally written as follows:

$$R_{opt}^{2} = \frac{R_{r}T_{g} - R_{g}T_{r}}{G_{g}T_{r} - R_{g}T_{g}}$$

$$T_o G_n = \frac{T_g}{R_g + R_{opt}^2 G_g} = \frac{G_g T_r - R_g T_g}{G_g R_r - R_g^2}$$

$$T_{\min} = \frac{1}{N} \left[ T - T_o G_n (R - 2R_{opt}N + R_{opt}^2 G) \right]$$

where  $R = \Sigma R_i$ ,  $G = \Sigma 1/R_i$ ,  $T = \Sigma T_i$ , and

$$R_{r} = (\Sigma R_{i})^{2} - N\Sigma R_{i}^{2}$$

$$R_{g} = \Sigma R_{i} \Sigma 1/R_{i} - N^{2}$$

$$G_{g} = (\Sigma 1/R_{i})^{2} - N\Sigma 1/R_{i}^{2}$$

$$T_{r} = \Sigma T_{i} \Sigma R_{i} - N\Sigma T_{i} R_{i}$$

$$T_{g} = \Sigma T_{i} \Sigma 1/R_{i} - N\Sigma T_{i}/R_{i}$$

#### How the Program Works

The program reads the number of points and values from data statements, computes the three noise parameters and the final error in temperature and presents the function T(R) in graphics mode.

Two operation modes are allowed:

Option = 0: uses the data as temperature and source

resistance values

Option = 1: uses the data as temperature,  $\lambda/4$  transformer impedance and 50 ohm line length (inches)

From this, it is clear that three values are required for each point and that the third one is not used in the zero option.

The scale in the plotting can be changed easily through the variables  $X_{max}$ and  $Y_{max}$  that are the maximum values for horizontal and vertical dimensions of the plot.

THIS PROGRAM COMPUTES THE MINIMUN TEMPERATURE AND OPTIMUN 10 ! SOURCE RESISTOR FROM A SET OF N MEASUREMENTS WITH THE 20 I MINIMUN CUADRATIC ERROR 30 40 PRINT LIN(2), "Ropt 1 as of 12/10/81" 50OPTION BASE 1 ! DATA must be placed in 470 to 510 as follows: N,T1,R1,L1,T2,R2,L2,... 60 ! Selact Option=0 for Ri=Rsource and Option=1 for R=Rtransformer and 78 L=50 ohm line length 80 INPUT "Option=",Option  $\otimes 1$ Fo=15 85 Qlam=11.8028527/(2\*Fo) 90 DIM Temp(20),Res(20),Long(20) 100 READ N 110 RED1M Temp(N), Res(N), Long(N) 120 R=G=T=Rr=ug=Tr=Tg=0 130 FOR I=1 TO N 140 READ Temp(1), Res(I), Long(I) 150 IF Option=0 THEN 170 152 L=PI\*Long(I)/(2\*Q)am) 160 Res(I)=Res(I)^2\*(1+TAN(L)^2)/(50\*(1+((Res(I)/50)^2\*TAN(L))^2)) 170 R=R+Res(I) 180 G=G+1/Res(I) 190 T=T+Temp(I) 200 Rr=Rr+Res(I)^2 210 Gg=Gg+1/Res(I)^2 220 Tr=Tr+Temp(I)\*Res(I) 230 Tq=Tq+Temp(I)/Res(I) 240 NEXT I 250 Rr=R^2-N\*Rr 260 Ra=R\*G-N^2 270 Gg=G^2-N\*Gg 280 Tr=T\*R-N\*Tr 290 Tg=T\*G-N\*Tg 300 Ropt=SQR(ABS((Rg\*Tr-Rr\*Tg)/(Rg\*Tg-Gg\*Tr))) 310 Gn=Tr/(Rr+Ropt^2\*Rg) 320 Tmin=T/N+Gn\*(R/N+2\*Ropt+G\*Ropt^2/N) 330 Error=0 340 FOR I=1 TO N 350 Error=Error+(Tmin+Gn\*(Ropt-Res(I))^2/Res(I)-Temp(I))^2 360 NEXT I 370 Error=SQR(Error/N) 380 Gn=Gn/290 390 INPUT "Print title in less than 18 characters",A\$ 400 PRINT LIN(1), TAB(20); A\$ 410 PRINT " PRINT LIN(1), "Minimun temperature Tmin=":Tmin 420PRINT "Optimun resistece Ropt=";Ropt 430 440 PRINT "Noise conductance Gn =";Gn 450 PRINT "Mean square error Err =";Error 460 PRINT LIN(1),' 470 DATA 3 480 DATA 75.5,34,.07 490 DATA 46.9,22,.055 500 DATA 31.7.12,.052 510DATA 66.7,34,0 520 GRAPHICS 521Xmax=12 522 -Yma×=110 530 SCALE -.1+Xmax,Xmax,-.1\*Ymax,Ymax 540 AXES 10,50,0,0,5,2,5 550 LINE TYPE 1 560 LORG 6 570 MOVE -.03\*Xmax,-.03\*Ymax 580 LABEL USING "K";"0" 594 MOVE 10, -.03\*Ymax 600 LABEL USING "k";"10"

```
610 MOVE .5*Xmax,-.07*Ymax
    LABEL USING "K"; "Rsource(ohm)"
620
630
    LORG 8
640 MOVE -.03*Xmax,100
650 LABEL USING "K"; "100"
660 MOVE -.03+Xmax,.8*Ymax
670 LABEL USING "K"; "T(K)"
680
    LORG 5
690
    FOR I=1 TO N
    MOVE Res(I), Temp(I)
700
    LABEL USING "K"; "+"
710
    NEXT I
720
730
    FOR Ri=.0!*Xmax TO Xmax STEP .01*Xmax
740
    Ti=Tmin+290*Gn*(Ri-Ropt)^2/Ri
750 PLOT Ri, Ti
760
    NEXT Ri
770
    PAUSE
    RESTORE
771
    GOTO 100
772
780
    END
```

Appendix 1. Program "Ropt 1" for HP-9845A Computer

#### Appendix 2

#### NE-137 and MGF-1412 Models

The circuit models used in the computer programs for the NE-137 and MGF-1412 FET's are shown in Figures A2-1 and A2-2, where the package is outside the dotted lines.

The scattering parameters computed from these models and the computer program which calculates the transistor performances at any frequency are included in Figures A2-3 to A2-6.

The computer description of the circuit models is as follows:

7955	Fet:! NE 737 Mode) at 300K - 01/27/82	
2960	DISP "Hualyzing the ckt model FREQ =";F	
7965	CALL R1((A(*),"S",0,0,.036."S",0)	102
1970	CRLL State(B(*),"V","C",45.6,1E7,400.9,1.28)	!gm,R4,T
7975	CALL Par(B(*),A(*))	
7930	CALL R12(A(*), "S",0,0,.270,"P",0)	1 C 1
7985	CALL Cas(A(*),B(*))	
7990	CALL RIC(B(*),"S",0.0,.132,"P",0)	103
2995	CALL Cha(*),B(*))	
8069	CHL! RIC(B(*),"S",4.4,.106,0,"P",0)	!R2,L2
8662	CHLL Ser(B(*),A(*))	
8010	UNL. MI((H(*),"S",6.99,.081,0,"S",0)	'R1,L1
8015	UHLL UER(H(*),B(*))	
-0828 -0208	CHLL RIC(B(*),"S",4,.090,0,"S",0)	!R3,L3
8020	UHLU UAA(H(*),B(*)) CRUU Di (R(*) Horo o o or yrru si	
0030	UALL KI((B(*),"S",0,0,.01,"P",0)	104
0000	しいした しほらたおに大ノ。目に大ノノ Turity オンシンドマル島	INE 13700 in LBJ
0000	1017-1027F/10 Dame -7 7051F/F	
0007	NUNATED CONTRACTOR	
0000	NUMERAL SUCTIONS OF THE SECOND	
0007 0070	COLL HIGHLIVIZ COLL HIGHLIVIZI A Taim Dave Vene C.V	
9071 2071	CALL ATOMACE(#7,4,10010,Kupt,Aopt,207 CALL PITTERATION & ORA & NON A.	
8072	CALL KICHANN, O ,0, 000,0, 0 ,07 (811 CustR(*) A(*))	Packaging L's
8975	Ú811 (>>(8(*) B(*))	
8076	CALL R), (B(*), "S", 0, 0., 150, "P" 0)	Packaging C/c
8077	CALL Cas(A(*), B(*))	Hackaying C S
8078	CALL Cas(B(*).A(*))	
8879	CALL R1:(A(*),"P",0.,03.0."P",0)	lSource L-C
8080	CALL Ser(A(*),B(*))	<ul> <li>Test test test to test test test</li> </ul>
8165	DISP	
8178	PETURN	

2955	Fet: F	16F-1412 model	
2960	DISP	"Analyzing the ckt model FREQ =";F	
2965	CALL	R1((A(*),"S",0,0,.031,"S",0)	102
7770	CALL	Suurce(B(*),"V","C",44.0,1E7,500.0,5)	!gm,R4,T
7975	CALL	Parr B(*), A(*))	
7980	CALL.	R1.(A(*),"S",0,0,.500,"P",0)	! C 1
7985	CALL	Cas(A(*),B(*))	
7990	CALL	R(c(B(*),"3",0,6350,"P",0)	103
7995	CALL	CastA(*),B(*))	
8666	CALL	R1c(B(*),"S",2.3,.009,0,"P",0)	!R2,L2
8005	CALL	S⇔+/B(*),A(*))	
0010	CALL	Rlc(A(≁),"S",4,.100,0,"S",0)	!R1,L1
8015	CALL	Cas(A(*),B(*))	
8020	CALL	R1c(B(*),"S",3,.050.0,"S",0)	!R3,L3
8025	CALL	Cas(A(*),B(*))	
8030	CALL	Rlc(B(*),"S",0,0,.01,"P",0)	104
8035	CALL	CaskB(*),A(*))	IChip model in [B]
8036	Tmin	:290★F/15	
8837	Republic	-12.5*15/F	
3038	Xopt	<16.3*15/F	
8639	Gn≠≦e	6.8+(F/15)^2	
8840	CHLL	N(nad(B(*),4,Tmin.Ropt,Kopt,Gn)	!Noise model at 300K
8065	CALL	R1c(A(*),"S",0,.300.0,"S",0)	!Packaging L's
8070	CALL	CasyB(*),A(*))	
8075	CALL	СцыкА(*),В(*))	
807 <i>6</i>	CHLL	R1c(B(*),"S",0.0,.450,"P",0)	!Packaging Cout
8079	CHLL	Cas(A(*),B(*))	
8080	CALL	R) ·B(*),"S",0,0,.250,"P",0)	!Packaging Cin
8081	CALL	Car(B(*),A(*))	
8082	CALL	Ric(A(*),"P",0,.03,0,"P",0)	!Source L-C
8083	CAL'	Ser(A(*),B(*))	
8165	DISF		
8170	RETURN		
8260	SUBLIND		



Fig. A2-1. Circuit model of NE13783.

MGF-1412



Fig. A2-2. Circuit model of MGF-1412.



Fig. A2-3. S11 and S22 of NE13783 model.



Fig. A2-4. S21 and S12 of NE13783 model.



Fig. A2-5. S11 and S22 of MGF-1412 model.



Fig. A2-6. S12 and S21 of MGF-1412 model.

#### Appendix 3

#### Noise Measurement Errors

In this analysis we are going to look only at the errors in the noise measurements due to the second stage or receiver noise when it is taken into account and substracted from the total noise measured.

Let us define the receiver as shown in Fig. 4 where  $R_{ij}$  are the scattering parameters and  $n_{20}$ ,  $n_{2i}$  are the noise waves at the receiver input.

In the calibration process, the power in the load can be written as:

$$P_{L} = |R_{21}|^{2} \cdot \frac{|T_{21} + T_{20}|\Gamma_{s}|^{2} + 2Re(\Gamma_{s}\zeta_{2}) + T_{s}(1 - |\Gamma_{s}|^{2})|}{|1 - \Gamma_{s}R_{11}|^{2}}$$

or  $P_{L} = G_{R}(T_{R} + T_{s})(1 - |\Gamma_{s}|^{2})$  where

$$G_{R} = \left| \frac{R_{21}}{1 - \Gamma_{s}R_{11}} \right|^{2}$$

$$T_{R} = \frac{T_{21} + T_{20}|\Gamma_{s}|^{2} + 2Re(\Gamma_{s}\zeta_{2})}{1 - |\Gamma_{s}|^{2}}$$

$$T_{21} = \overline{|n_{21}|^{2}}$$

$$T_{20} = \overline{|n_{20}|^{2}}$$

$$\zeta_{2} = \overline{n_{20}n_{21}^{*}}$$

Using two source temperatures  $(T_1, T_0)$ , with excess noise  $N_s = T_1/T_0 - 1$ , the receiver temperature and gain can be computed as follows:

$$T_{R} = T_{O} \left( \frac{N_{S}}{N_{R}} - 1 \right)$$

$$G_{R} = \frac{1}{1 - |\Gamma_{s}|^{2}} \cdot \frac{P_{o}}{T_{o}} \left( \frac{N_{R}}{N_{s}} \right)$$

where  $N_R = \frac{P_1}{P_0} - 1$ ,  $P_0 = P_L(T_s = T_0)$  and  $P_1 = P_L(T_s = T_1)$ 

In the most general situation, the device under test can be described as shown in Figure A3-2. When it has been inserted, the power in the load is:

$$P_{L}' = \frac{|R_{21}|^{2}}{|1 - \Gamma_{2}R_{11}|} \left[ T_{21} + |\Gamma_{2}|^{2} \cdot T_{20} + 2Re(\Gamma_{2} \cdot \zeta_{2}) + \frac{|S_{21}|^{2}}{|1 - \Gamma_{1}\Gamma_{s}|^{2}} \left( T_{11} + T_{10}|\Gamma_{s}|^{2} + 2Re(\Gamma_{s}\zeta_{1}) + T_{s}(1 - |\Gamma_{s}|^{2}) \right) \right]$$

or  $P_{L} = G_{Re}[T_{Re}(1 - |\Gamma_{2}|^{2}) + G_{A}(T_{A} + T_{s})(1 - |\Gamma_{s}|^{2})]$ 

where

$$G_{\text{Re}} = \frac{\left| R_{21} \right|^2}{\left| 1 - \Gamma_2 R_{11} \right|^2}$$

$$G_{A} = \frac{|S_{21}|^{2}}{|1 - \Gamma_{s}\Gamma_{1}|^{2}}$$

$$T_{Re} = \frac{T_{2i} + T_{20} |\Gamma_e|^2 + 2Re(\Gamma_2 \zeta_2)}{1 - |\Gamma_2|^2}$$

$$T_{A} = \frac{T_{11} + T_{10} |\Gamma_{s}|^{2} + 2Re(\Gamma_{s}\zeta_{1})}{1 - |\Gamma_{s}|^{2}}$$

In the same way as in the calibration process, the total input noise and gain can be computed as:

$$T_{T} = T_{o} \left( \frac{N_{s}}{N_{A}} - 1 \right)$$

•

$$G_{\mathrm{T}}(1 - |\Gamma_{\mathrm{s}}|^{2}) = \frac{P_{\mathrm{o}}'}{T_{\mathrm{o}}} \cdot \frac{N_{\mathrm{A}}}{N_{\mathrm{s}}}$$

where  $N_A = \frac{P'_1}{P'_0} - 1$ ,  $P'_0 = P'_L(T_s = T_0)$  and  $P'_1 = P'_L(T_s = T_1)$ 

Using the gain and noise definitions as before, it follows that:

$$T_{T} = T_{A} + T_{Re} \cdot \frac{(1 - |\Gamma_{2}|^{2})}{G_{A}(1 - |\Gamma_{S}|^{2})} = T_{A} + \frac{T_{Re}}{G_{av}}$$

$$G_{T} = G_{Re} \cdot G_{A}$$

It can be seen that the values for the receiver noise and gain used in these equations are not exactly the same values measured in the calibration process.

First, the computed gain is

$$G'_{av} = G_T/G_R$$

or using the available gain as before

$$G_{A} = G_{av} \left[ \frac{(1 - |\Gamma_{s}|^{2}) |1 - \Gamma_{2}R_{11}|^{2}}{(1 - |\Gamma_{2}|^{2}) |1 - \Gamma_{s}R_{11}|^{2}} \right]$$

On the other hand, the receiver noise changes as the source impedance does, and the real noise can be written as a function of the measured one as follows:

$$T_{Re} = (T_R + \Delta T) \cdot \frac{1 - |\Gamma_s|^2}{1 - |\Gamma_2|^2}$$

where 
$$\Delta T = \frac{1}{1 - |\Gamma_{s}|^{2}} \left[ T_{20}(|\Gamma_{2}|^{2} - |\Gamma_{2}|^{2}) + 2Re(\zeta_{2}(\Gamma_{2} - \Gamma_{s})) \right]$$

The final error in the amplifier noise temperature is:

$$\Delta T_{A} = \Delta T \cdot \frac{1}{G_{av}} \left| \frac{1 - \Gamma_{s}R_{11}}{1 - \Gamma_{2}R_{11}} \right|^{2} - \frac{T_{Rm}}{G_{av}'} \left( 1 - \left| \frac{1 - \Gamma_{s}R_{11}}{1 - \Gamma_{2}R_{11}} \right|^{2} \right)$$

١

where the first term is mainly due to the variation in the receiver noise temperature when changing its source impedance and the second one is due to the error in the amplifier available gain and the second stage noise contribution.

If the second stage is connected through an isolator at temperature  $T_i$  and the noise source is well-matched, as usually happens, the error can be written as follows:

$$\Delta T_{A} \simeq \frac{T_{1} \cdot |\Gamma_{2}|^{2}}{G|1 - \Gamma_{2}R_{11}|^{2}} - \frac{T_{Rm}}{G} \left(1 - \frac{1}{|1 - \Gamma_{2}R_{11}|^{2}}\right)$$

which is limited, depending on the sign of  $\Gamma_2$  and  $R_{11}$  phases by the maximum and minimum values as follows:

$$\Delta T_{Amax} = \left( T_{i} | \Gamma_{2} |^{2} + 2T_{Rm} | \Gamma_{2} R_{11} | \right) \cdot \frac{1}{G \cdot (1 + | \Gamma_{2} R_{11} |)^{2}}$$
$$\Delta T_{Amin} = \left( T_{i} | \Gamma_{2} |^{2} - 2T_{Rm} | \Gamma_{2} R_{11} | \right) \cdot \frac{1}{G(1 + | \Gamma_{2} R_{11} |)^{2}}$$

where G = amplifier measured gain.

#### Appendix 4

#### Amplifier Design Computer Programs

The most important programs which compute the matching networks and analyze the amplifier frequency response are presented in this appendix.

#### Two-Stage Amplifier Design "Man #4"

This program computes a two-stage amplifier for minimum noise and optimizes the input return loss changing the inter-stage free parameter.

The method is as follows:

- 1. Compute the transistor model and get Ropt.
- 2. Loading the input with Ropt, compute Rout.
- Compute the input return loss for three values of the inter-stage "trombone line" (free parameter).
- 4. As the three values for the input reflection coefficient must be in a circle, it is easy to know the minimum and go back with this point to the inter-stage circuit.
- 5. Compute the circuit parameters and print these.
- 6. Compute the frequency response and plot it.

The list and usual printout are presented here for the NE-137 room temperature amplifier model (two-stage).

Man#4 as of 8/20/8	<u>1</u>		
Design frequency= 15	Source L1= .03	Source	L2= .03
Optimun noise impedance=			
	First stage Zopt=	7.74900446231 j	22.0042182449
	Second stage Zopt=	7.74900446231 j	22.0042182449
Trombone length= .170983	Rin1= 52.218 Xin1	1=-2.33208	
Line number 1 Zo= 17.9864	Length=	.196714	
Line number 2 – Zo= 50	Length=	.0528602	
Line number 3 – Zo= 50	Length=	.0920018	
Line number 4 Zo= 12.9635	Length=	.196714	
Line number 5 Zo= 50	Length=	.170983	
Line number 6 Zo= 17.9864	Length=	.196714	
Line number 7 Zo= 50	Length=	.0528602	
Line number 8 – Zo= 50	Length=	.0920018	
Line number 9 Zo= 12.9635	Length=	.196714	



6195 SUB Cktanalysis(J(\*), Fvalue, Opt) 6205 PRINT LIN(2); TAB(10); "Man#4 as of 8/20/81" 6215 OPTION BASE 1 6225 COM Nogo, Zo, F, Count, SHORT Dat (51, 18) / [DAT] HOLDS FREQ, CKT AND NOISE DATA 6235 DIM A(6,4),B(6,4),C(6,4),B(6,4),E(4,4),Y(9),Z(8),W(9) 6245 STANDARD **!#FREQS CURRENTLY STORED IN DATA BASE** 6255 Count=Nodo=0 6265 Zt=50 6275 Zo=50 6285 DEG IDEFAULT FOR TRIG FUNCTIONS IS DEGREES 6295 REM USER'S PROGRAM SHOULD BEGIN ON THE NEXT LINE, USING AN INCREMENT OF 10. 6305 ! This program computes a two-stage amp. matched for optimun noise 6315 ! and output return loss in both stages, and select the interstage 6325 ! line length (Trombone line) for optimun input match @ Fo. 6335 Fo=15 6345 F1=13 6355 F2=17 6365 Df=.100 6375 F=Fo 6385 Qlam=11.8028527/(4\*F) 6395 INPUT "Source L1 and L2 =",L1,L2 6405 L=L1 6415 GOSUB Fet 6425 MAT C=A 6435 CALL Ntrans(C(\*),4) 6445 Ropt1=C(6,2) 6455 Xopt1=C(6,3) 6465 L=L2 6475 GOSUB Fet 6485 CALL Ntrans(A(\*),4) 6495 Ropt2=A(6,2) 6505 Xopt2=A(6,3) 6515 PRINT "Design frequency=";F;TAB(30);"Source L1=";L1;TAB(60);"Source L2=";L2 6525 PRINT "Optimun noise impedance=" 6535 PRINT TAB(30); "First stage Zopt=";Ropt1;" j";Xopt1 6545 PRINT TAB(30); "Second stage Zopt=";Ropt2;" i":Xopt2 6555 CALL Zio(C(\*), Ropt1, Xopt1,0,0,0,0,Z(3),Z(4),1) 6565 CALL Zio(A(\*), Ropt2, Xopt2, 0, 0, 0, 0, Z(7), Z(8), 1) 6575 CALL Cammaz(-1,C,D,Ropt1, Nopt1) 6585 Y(1)=2o\*SQR((1+C)/(1+C)) 6595 W(1)=01am 6605 Y(2)=20 6615 W(2)=(1-D/180)\*Qlam 6625 Zo=Zt 6635 CALL Gammaz(-1,C,D,Z(3),Z(4)) 6645 Y(3)=20 6655 W(3)=(1+D/180)\*0)am 6665 Y(4)=Zo\*SQR((1+C)/(1+C)) 6675 W(4)=01am 6685 CALL Gammaz(-1,C,D,Ropt2,Xopt2) 6695,Y(6)=Zo\*SQR((1+C)/(1+C)) 6705 W(6)=01am 6715 Y(7)=Zo 6725 W(7)=(1-D/180)\*01am 6735 Zo=50 6745 CALL Gammaz(-1,C,D,Z(7),Z(8)) 6755 Y(9)≃Zo\*SOR((1-C)/(1+C)) 6765 W(9)=Qlam 6775 Y(8)=Zo 6785 W(8)=(1+D/180)\*01am 6795 L=L1 6805 K=1 6815 GOSUB Circuit

=Ĥ

6855 GOSUB Circuit

6845 K=2

```
6865 CALL Zio(A(*).0.0.50.0.Z(5).Z(6).0.0.1)
6875 E=0
6885 FOR K=1 TO 3
6895
       Zo=Zt
       CALL Gammaz(-1, A, B, Z(5), Z(6))
6905
6915
       H=B-2*E
       CALL Gammaz(1, A, H, E(1, K), E(2, K))
6925
6935
       Zo=50
       CALL Zio(C(*),0,0,E(1,K),E(2,K),E(3,K),E(4,K),0,0,1)
6945
6955
       CALL Gammaz(-2,E(1,K),E(2,K),E(3,K),E(4,K))
       E(3,K)≈E(1,K)^2+E(2,K)^2
6965
6975
       E=E+60
6985 NEXT K
6995 D=(E(2,1)-E(2,3))*(E(1,1)-E(1,2))-(E(2,1)-E(2,2))*(E(1,1)-E(1,3))
7005 IF D=0 THEN 7105
7015 E(1,4)=E(2,1)*(E(3,3)-E(3,2))+E(2,2)*(E(3,1)-E(3,3))+E(2,3)*(E(3,2)-E(3,1))
7025 E(2,4)=E(1,1)*(E(3,3)-E(3,2))+E(1,2)*(E(3,1)-E(3,3))+E(1,3)*(E(3,2)-E(3,1))
7035 E(1,4)≈E(1,4)/(2*D)
7045 E(2,4)=-E(2,4)/(2*D)
7055 R=SQR((E(1,4)-E(1,1))^2+(E(2,4)-E(2,1))^2)
7065 D=SQR(E(1,4)^2+E(2,4)^2)
7075 E(3,4)=E(1,4)*(1-R/D)
7085 E(4,4)=E(2,4)*(1-R/D)
7095 GOTO 7135
7105 D=(E(2,1)%E(1,2)~E(2,2)*E(1,1))/((E(1,1)-E(1,2))^2+(E(2,1)-E(2,2))^2)
7115 E(3,4)=(E(2,1)-E(2,2))*D
7125 E(4,4)=(E(1,2)-E(1,1))*D
7135 CALL Gammaz(2,E(3,4),E(4,4),C,D)
7145 CALL Zio(C(*),0,0,Z1,Z2,C,D,0,0,-1)
7155 Zo=Zt
7165 CALL Gammaz(-1,G,H,Z1,Z2)
7175 IF ABS(A-G)(1E-6 THEN 7215
       PRINT "Gamma in both ends of the trombone line don't match"
7185
7195
       PRINT "Left end abs. gamma=";G;"Right end abs. gamma=";A
7205
       PAUSE
7215 E=(B-H)*01am/180
7225 IF E<0 THEN E=E+2*01am
7235 Zo=50
7245 PRINT "Trombone length=";DROUND(E,6);
                                      Xin1=";DROUND(D.6)
               Rin1=";DROUND(C,6);"
7255 PRINT "
7265 INPUT "Do you want to change the trombone length?",A$
7275 IF A≸≈"N" THEN 7305
7285 INPUT "Trombone length=",E
7295 PRINT "New trombone length =";E
7305 Y(5)=2t
7315 W(5)=E
7325 FOR K≈1 TU 9
       PRINT "Line number";K;"
                                Zo=";DROUND(Y(K),6),"Length=";DROUND(W(K),6)
7335
7345 NEXT K
7355 FOR F=F1 TO F2 STEP Df
7365
       Lale
7375
       K≈2
7385
       GOSUB Circuit
7395
       MAT C=A
7405
       L=L1
7415
       k = 1
7425
       GOSUB Circuit
7435
       CALL Trline(B(*),Y(5),W(5),1)
7445
       CALL Cas(B(*), C(*))
7455
       CALL Cas(A(*), B(*))
7465
       CALL Saveckt(A(*), 4, 4, -1)
7475
       CALL Nperformance(A(*),0,50,0,50,0,G,1)
```

5 NEXT F 5 GRAPHICS 7505 SCALE F1,F2,-30,0 7515 C=4/236.2 !GHz/mm 7525 D=30/162.5 !dB/mm 7535 LINE TYPE 3 7545 AXES 1,2,Fu,-10 7555 AXES 1.10.Fo.-20 7565 LINE TYPE 5 7575 FOR K=1 TO Count 7585 PLOT Dat(K,1),10\*LGT(Bat(K,2)^2+Dat(K,3)^2) |S11 is dot-dashed 7595 NEXT K 7605 PENUP 7615 LINE TYPE 3 7625 FOR K=1 TU Count Indise is dashed 7635 PLOT Dat(K,1), Dat(K,14)/20-30 7645 NEXT K 7655 PEHUP 7665 LINE TYPE 1 7675 FOR K=1 T0 Count 7685 7695 NEXT K 7705 PENUP 7715 LINE TYPE 7 7725 FOR K=1 TO Count 7735 PLOT Dat(F,1),10\*LGT(Dat(K,8)^2+Dat(K,9)^2) IS22 is dble dot dash 7745 NEXT K 7755 LORG 1 7765 G=1 7775 LINE TYPE 1 7785 FOR F=F1 TO F2 STEP 2 IF F<F2 THEN 7825 7795 G=--1 7805 LORG 7 7815 7825 MOVE F+G+C,D-30 LABEL USING "K";F 7835 7845 NEXT F 7855 LDIR 90 7865 FOR G=-20 TO 0 STEP 10 MOVE F2-C,G-D 7875 7885 LABEL USING "K";G 7895 MOVE Fo-C,G-D LABEL USING "K";20\*(G+30) 7905 7915 NEXT G 7925 LORG 4 7935 MOVE F2-5\*C,-15 7945 LABEL USING "K"; "IRG" 7955 MOVE Fo-5\*C,-15 7965 LABEL USING "K"; "NOISE" 7975 LORG 6 7985 MOVE F1+5\*C,-15 7995 LABEL USING "K"; "GAIN" 8005 LORG 9 8015 FOR G=-20 TO 0 STEP 10 MOVE F1+C,G-D 8025 LABEL USING "K";G+20 8035 8045 NEXT G 8055 LDIR 0 8065 FRAME 8075 PAUSE 8085 GOTO 7495 8095 SUBEXIT 8105 Circuit:! 8115 GOSUB Fet CALL Trine(B(\*),Y(5\*K-3),W(5\*K-3),1) 8125 8135 CALL Cas(B(\*),A(\*))

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```
8145
       CALL Trline(A(*),Y(5*K-2),W(5*K-2),1)
8155
       CALL Cas(B(*),A(*))
8165
       CALL Trline(A(*),Y(5*K-4),W(5*K-4),1)
8175
       CALL Cas(A(*),B(*))
8185
       CALL Trline(B(*),Y(5*K-1),W(5*K-1),1)
8195
       CALL Cas(A(*),B(*))
8205
       RETURN
                                        01/27/82
8215 Fet:! NE-137 Model at 300K
8220
     DISP "Analyzing the ckt model . . . FREQ =";F
       CALL Ric(A(*), "S",0,0,.036, "S",0)
                                                              102
8225
       CALL Source(B(*), "V", "C", 45.6, 1E7, 400.9, 1.28)
8230
                                                              lgm,R4,T
8235
       CALL Par(B(*), A(*))
8240
       CALL R1c(A(*), "S",0,0,.270, "P",0)
                                                              101
       CALL Cas(A(*), B(*))
8245
                                                              103
8250
       CALL R1c(B(*), "S",0,0,.132, "P",0)
8255
       CALL Cas(A(*),B(*))
8260
       CALL R1c(B(*), "S", 4.4, .106,0, "P",0)
                                                              !R2,L2
8265
       CALL Ser(B(*),A(*))
       CALL Ric(A(*), "S", 6.99, .081, 0, "S", 0)
8270
                                                              !R1.L1
       CALL Cas(A(*),B(*))
8275
       CALL R1c(B(*), "S", 4, .09,0, "S",0)
8280
                                                              !R3,L3
       CALL Cas(A(*),B(*))
8285
8290
       CALL Ric(B(*), "S",0,0,.01, "P",0)
                                                              104
8295
       CALL Cas(B(*),A(*))
                                                              !NE 13700 in [B]
       Tmin=182*F/15
8300
8305
       Ropt=6.64*15/F
8310
       Xopt=27.33*15/F
8315
       Gn=26.5*(F/15)^2
       CALL Nload(B(*),4,Tmin,Ropt,Xopt,Gn)
8320
                                                              !Noise model
       CALL Ric(A(*), "S",0,.350,0, "S",0)
8325
                                                              !Packaging L's
8330
       CALL Cas(B(*),A(*))
8335
       CALL Cas(A(*),B(*))
       CALL Ric(B(*), "S",0,0,.150, "P",0)
8336
                                                              !Packaging C's
8337
       CALL Cas(A(*),B(*))
8338
       CALL Cas(B(*), A(*))
       CALL Ric(A(*), "P",0,L,0, "P",0)
8339
                                                              !Source L
       CALL Ser(A(*),B(*))
8340
       CALL Trline(B(*),120,.196,1)
8344
                                                              !Bias line
8345
       CALL R1c(D(*), "P", 50, 0, 1, "P", 0)
8350
       CALL Cas(B(*),D(*))
8355
       CALL Branch(B(*),"P")
8360
       CALL Cas(A(*),B(*))
       CALL Cas(B(*),A(*))
8365
8395
       CALL Trline(A(*),38,.085,1.8)
                                                              !Output coupling C
8400
       CALL Branch(A(*), "S")
8405
       CALL Cas(B(*),A(*))
8410
       CALL Trline(A(*),38,.085,1.8)
                                                              !Input coupling C
8415
       CALL Branch(R(*),"S")
8420
       CALL Cas(A(*),B(*))
8425
       DISP
8430 RETURN
8435 END
```

One to Three Stage Amplifier Design ("Amp #1")

This program allows one to compute the one, two or three stage amplifier, matching each stage for minimum noise or maximum gain as desired.

It does not compute the inter-stage "trombone line" that must be entered during the program execution to allow other than the input match adjustments.

The list and usual printout are presented.

Amp#1 as of 9/16/81 Design frequency = 15Stage # 1 Source L1= .03 Source C1= 0 Minimun noise Z= 7.749 22.0042 Tmin= 190.665 Ga = 9.28587 Maximun gain Z= 5.90394 20.7877 Ta = 196.333 Gmax= 9.35016 Min. N. Measure Z= 7.62539 21.9072 Ta = 190.687 Ga = 9.29371 Stage # 2 Source L1= .03 Source C1= 0 Minimun noise Z= 7.749 22.0042 Tmin= 190.665 Ga = 9.28587 Maximun qain Z= 5.90394 20.7877 Ta = 196.333 Gmax= 9.35016 Min. N. Measure Z= 7.62539 21.9072 Ta = 190.687 Ga = 9.29371 Stage # 3 Source L1= .03 Source C1= 0 Z= 7.749 22.0042 Tmin= 190.665 Ga = 9.28587 Minimun noise Z= 5.90394 20.7877 Ta = 196.333 Gmax= 9.35016 Maximun gain Min. N. Measure Z= 7.62539 21.9072 Ta = 190.687 Ga = 9.29371 Line number 1 Zo= 17.8563 Length= .196714 Zo= 50 Line number 2 Length= .0526249 Line number 3 Zo= 50 Length= .092043 Line number 4 Zo= 12.883 Length= .196714 Line number 5 Zo= 50 Length= .2 Line number 6 Zo= 17.8563 Length= .196714 Zo= 50 Line number 7 Lenath= .0526249 Line number 8 Zo= 50 Length= .092043 Line number 9 Zo= 12.883 Length= .196714 Line number 10 Zo= 50 Length= .2 Line number 11 Zo= 17.8563 Length= .196714 Line number 12 Zo= 50 Length= .0526249 Line number 13 Zo= 50 Length= .092043 Line number 14 Zo= 12.883 Length= .196714



Cktanalysis(J(\*), Fvalue, Opt) 6215 OPTION BASE 1 6225 COM Nogo,Zo,F,Count,SHORT Dat(51,18) /[DAT] HOLDS FREQ, CKT AND NOISE DATA 6235 DIM A(6.4), B(6.4), C(6.4), D(6.4), Y(15), W(15), L(3), Cap(3) 6245 STANDARD 6255 Count=Nogo=0 **!#FREQS CURRENTLY STORED IN DATA BASE** 6265 Zo=50 6275 DEG IDEFAULT FOR TRIG FUNCTIONS IS DEGREES 6285 REM USER'S PROGRAM SHOULD BEGIN ON THE NEXT LINE, USING AN INCREMENT OF 10. 6295 ! This program computes one, two or three stage amp. tuned for 6305 ! minimun noise, maximun gain or minimun noise figure. 6315 N=3 6325 Fo=15 6335 F1=13 6345 F2=17 6355 Df=.100 6365 F=15 6375 Qlam=11.8028527/(4\*Fo) 6385 INPUT "Source L1 and C1 =".L(1).Cap(1) 6395 IF N=1 THEN 6435 6405 INPUT "Source L2 and C2 =",L(2),Cap(2) 6415 IF N=2 THEN 6435 6425 INPUT "Source L3 and C3 =",L(3),Cap(3) 6435 PRINT "Design frequency =";F 6445 FOR K=1 10 N Ls=L(K) 6455 6465 Cs=Cap(K)6475 GOSUB Fet 6485 CALL Nthans(A(\*),1) 6495 CALL Mtrans(A(\*),1) 6505  $R_0 = SQR(A(6, 1) / A(6, 2))$ 6515 X1=A(6,4)\*Ro/A(6,1) 6525 R1=SQR(1-X1^2) 6535 K1=A(6,3)\*Ro/A(6,1) 6545 Tmin=2\*290\*A(6,1)\*(K1+R1)/Ro 6555 S1=2+(A(1,1)+A(1,3)+A(1,2)+A(1,4))/Ro 6565 S2=2\*(A(3,1)\*A(3,3)+A(3,2)\*A(3,4))\*Ro 6575 T1=P(1,1)\*A(3,3)+A(1,2)\*A(3,4)+A(1,3)\*A(3,1)+A(1,4)\*A(3,2) T2≈A(1,2)\*A(3,3)-A(1,1)\*A(3,4)+A(1,4)\*A(3,1)-A(1,3)\*A(3,2) 6585 6595 Kf=S1\*S2-T2^2 6605  $K \approx 1$ IF (Kf(0) OR (T1(0) THEN Ks=-1 6615 IF Ks>0 THEN 6645 6625 PRINT "K<1 Simultaneus match is not possible" 6635 6636 GOTO 6675 6645 R2=SQR(S1\*S2+T2^2)/S2 6655 X2=-T2/S2 6665 Gmax=1/(T1+SQR(S1\*S2-T2^2)) A=(S1+S2-2\*K1\*(T1-1)+2\*X1\*T2)^2-4\*(S1\*S2-(T1-1)^2-T2^2)\*(1-K1^2-X1^2) 6675 D=(T1-1-K1\*S2)^2+(T2+X1\*S2)^2 6685 R3=((S2-S1-SQR(A))\*(T1-1-K1\*S2)-2\*(K1\*T2+X1\*(T1-1))\*(T2+X1\*S2))/(2\*D) 6695 6705 X3=((S2-S1-SQR(A))\*(T2+X1\*S2)+2\*(K1\*T2+X1\*(T1-1))\*(T1-1-K1\*S2))/(2\*D) 6715 PRINT "Stage #";K;TAB(30);"Source L1=";Ls;TAB(60);"Source C1=";Cs 6725 Ga=2\*R1/(S2\*(R1^2+X1^2)+2\*(R1\*T1+X1\*T2)+S1) 6735 Z=";DROUND(R1\*Ro,6);DROUND(X1\*Ro,6); PRINT TAB(10);"Minimun noise 6745 PRINT "Tmin=";DROUND(Tmin,6);"Ga =";DROUND(10\*LGT(Ga),6) 6755 IF KsK0 THEN 6795 6765 Ta=Tmin+290\*8(6,1)\*((R2-R1)^2+(X2-X1)^2)/(R2\*Ro) 6775 PRINT TAB(10); "Maximun gain Z=";DROUND(R2\*Ro,6);DROUND(X2\*Ro,6); PRINT "Ta =";DROUND(Ta,6);"Gmax=";DROUND(10\*LGT(Gmax),6) 6785 6795 Ta=Tmin+290\*A(6,1)\*((R3-R1)^2+(X3-X1)^2)/(Ro\*R3) 6805Ga=2\*R3/(S2\*(R3^2+X3^2)+2\*(R3\*T1+X3\*T2)+S1) PRINT TAB(10); "Min. N. Measure Z=":DROUND(R3\*Ro.6); DROUND(X3\*Ro.6); 6815 6825 PRINT "Ta =";DROUND(Ta,6);"Ga =";DROUND(10\*LGT(Ga),6) 6835 PRINT

```
select the optimum source impedance desired, using K,R1,R2.
         t \approx R3
6865
      Xopt=X3
      CALL Zio(A(*), Ropt*Ro, Xopt*Ro,0,0,0,0,R,X,1)
6875
       CALL Gammaz(-1.C.D.Ropt*Ro,Xopt*Ro)
6885
6895
       Y(5*K-4)=Zo*SQR((1-C)/(1+C))
6905
       W<5*K-4)≈Qlam
      Y<5*K~3≠≃Zo
6915
      W(5 \times (-3) = (1 - D \times 180) \times 0) am
6925
      CALL Gammaz(-1.C.D.R.X)
6935
6945
      Y(5*K-2)=Zo
      W(5*K-2)=(1+D/180)*Q1am
6955
6965
       Y(5*K-1)=Zo*SQR((1+C)/(1+C))
6975
      |W(5*K-1)≠Qlam
6985
      IF K=N THEN 7035
      .! Insert here the phisical length of the line between this stage
6995
7005
      ! and the next one
      INPUT "Trombone line following this stage ?",W(5*K)
7015
7825
      -Y(5*K)≈Zo
7035 NEXT K
7045 FOR K=1 TO 5*N-1
       PRINT "Line number";K;" Zo=";DROUND(Y(K),6),"Length=";DROUND(W(K),6)
7055
7065 NEXT K
7075 FOR F=F1 TO F2 STEP Df
7085
       FOR K=1 TO N
7095
        Ls=L(K)
7105
        Cs=Cap(K)
        GOSUB Circuit
7115
7125
         IF K=N THEN 7155
         CALL lrline(B(*),Y(5*K),W(5*K),1)
7135
7145
        CALL Cas(A(*),B(*))
7155
        IF K≈1 THEN 7185
7165
        CALL (as(C(*).A(*))
         GOTO 7195
7175
         MAT C=A
7185
       NEXT K
7195
       CALL Saveckt(C(*),4,4,-1)
7205
7215
       CALL Nperformance(C(*),0,50,0,50,0,G,1)
7225 NEXT F
                                                                     IGGGGGGGGGG
7235 GRAPHICS
7245 SCALE F1.F2.-30.0
7255 C=4/236.2
                                                           1GHz/mm
7265 D=30/162.5
                                                           !dB/mm
7275 LINE TYPE 3
7285 AXES 1,2,Fo,-10
7295 AXES 1,10,Fo,-20
7305 LINE TYPE 5
7315 FOR K=1 TO Count
       PLOT Dat(K,1),10*LGT(Dat(K,2)^2+Dat(K,3)^2)
7325
                                                          !S11 is dot-dashed
7335 NEXT K
7345 PENUP
7355 LINE TYPE 3
7365 FOR K=1 TO Count
                                                            Incise is dashed
7375
       PLOT Bat(K,1), Dat(K,14)/20-30
7385 NEMT K
7395 PENUP
7405 LINE TYPE 1
7415 FOR K=1 TO Count
       7425
7435 NEXT K
7445 PENUP
7455 LINE TYPE 7
7465 FOR K=1 TO Count
7475 PLOT Dat(K,1),10*LGT(Dat(K,8)^2+Dat(K,9)^2)
                                                          !S22 is dble dot dash
7485 NEXT K
7495 LORG 1
```

;=1 .INE TYPE 1 FOR F=F1 TO F2 STEP 2 1.5 million 7535 IF F<F2 THEN 7565 7545 G=-1 7555 LORG 7 7565 MOVE F+G\*C, D-30 7575 LABEL USING "K";F 7585 NEXT F 7595 LDIR 90 7605 FOR G=-20 TO 0 STEP 10 MOVE F2-C,G-D 7615 7625 LABEL USING "K";G 7635 MOVE ForC,G-D 7645 LABEL USING "K";20\*(G+30) 7655 NEXT G 7665 LORG 4 7675 MOVE F2-5+C,-15 7685 LABEL USING "K"; "IRG" 7695 MOVE Fo-5\*C,-15 7705 LABEL USING "K"; "NOISE" 7715 LORG 6 7725 MOVE F1+5\*C,-15 7735 LABEL USING "K"; "GAIN" 7745 LORG 9 7755 FOR G=-20 TO 0 STEP 10 7765 MOVE F1+C,G-D LABEL USING "K";G+30 7775 7785 NEXT G 7795 LDIR 0 7805 FRAME 7815 PAUSE 7825 GOTO 7235 7835 SUBEXIT 7845 Circuit:! 7855 GOSUB Fet 7865 CALL Trline(B(\*),Y(5\*K-3),W(5\*K-3),1) 7875 CALL Cas(B(\*),A(\*)) CALL Trline(A(\*),Y(5\*K-2),W(5\*K-2),1) 7885 7895 CALL Cas(B(\*),A(\*)) 7905 CALL Trline(A(\*),Y(5\*K-4),W(5\*K-4),1) 7915 CALL Cas(A(\*),B(\*)) CALL Trline(B(\*),Y(5\*K-1),W(5\*K-1),1) 7925 CALL Cas(A(\*),B(\*)) 7935 7945 RETURN 7955 Fet:! NE-137 Model at 300K 01/27/82 7960 DISP "Analyzing the ckt model . . . . FREQ = ":FCALL Ric(A(\*), "S",0,0,.036, "S",0) 7965 102 7970 CALL Source(B(\*), "V", "C", 45.6, 1E7, 400.9, 1.28) !gm,R4,T 7975 CALL Par(B(\*),A(\*)) 7980 CALL Ric(A(\*), "S",0,0,.270, "P",0) 101 7985 CALL Cas(A(\*), B(\*)) CALL R1:(B(\*), "S",0,0,.132, "P",0) 7990 103 7995 CALL Cas(A(\*),B(\*)) CALL R1c(B(\*), "S", 4.4, .106, 0, "P", 0) 8000 !R2,L2 8005 CALL Ser(B(\*),A(\*)) CALL Ric(A(\*), "S", 6.99, .081,0, "S",0) 8010 !R1,L1 8015 CALL Cas(A(\*),B(\*)) 8020 CALL Ric(B(\*), "S", 4,.090,0, "S",0) !R3,L3 8025 CALL Cas(A(\*),B(\*)) 8030 CALL R1c(B(\*), "S",0,0,.01, "P",0) 104 CALL Cas(B(\*),A(\*)) 8035 !NE 13700 in [B] 8040 Tmin=182\*F/15 8045 Ropt=6.64\*15/F 8050 Xopt=27.33\*15/F

8055 Gn=26.5\*(F/15)^2

8060	CALL	Nload(B(*),4,Tmin,Ropt,Xopt,Gn)	Noise model
8865	CALL	Rlc(A(*),"S",0,.350,0,"S",0)	Packaging L's
8070	CALL	Cas(B(*),A(*))	2 2
8075	CALL	Cas(A(*),B(*))	
8076	CALL	Rlc(B(*), "S",0,0,.150, "P",0)	!Packaging C's
8077	CALL	Cas(A(*),B(*))	
8078	CALL	Cas(B(*),A(*))	
8079	CALL	Rlc(A(*),"P",0,Ls,Cs,"P",0)	!Source L-C
8080	CALL	Ser(A(*),B(*))	
8084	CALL	Tr)ine(B(*),120,.196,1)	!Bias line
8085	CALL	Ric(D(*),"P",50,0,1,"P",0)	
8090	CALL	Cas(B(*),D(*))	
8095	CALL	Branch(B(*),"P")	
8100	CALL	Cas(A(*),B(*))	
8105	CALL	Cas(B(*),A(*))	
8135	CALL	Trline(A(*),38,.085,1.8)	!Output coupling C
8140	CALL	Branch(A(*),"S")	
8145	CALL	Cas(B(*),A(*))	
8150	CALL	Trline(A(*),38,.085,1.8)	[Input coupling C
8155	CALL	Branch(A(*),"S")	
8160	CALL	Cas(A(*),B(*))	
8165	DISP		
8170	RETURN		
8175	END		

#### One to Three Stage Amplifier Analysis ("Amp #2")

The program allows the analysis of a one-, two- or three-stage amplifier with all the circuit parameters selected by the user.

It is possible to use it in two different modes by computing the frequency response (option = 0) or getting the spot center frequency response (option = 1) that allows a faster analysis and change in the circuit parameter.

Amp#2 as of 9/24/81

	Amp#2 as of	9/24/81		
Source	feedback FET	# 1	Ls= .03	Cs= 0
Source	feedback FET	# 2	Ls= .03	Cs= 0
Source	feedback FET	# 3	Ls= .03	Cs= Ø
LINE #	1	Zo= 18	Lengh= .1967	
LINE #	2	Zo= 50	Lengh= .053	
LINE #	3	Zo= 50	Lengh= .092	
LINE #	4	Zo= 12	Lengh= .1967	
LINE #	5	Zo= 50	Lengh= .171	
LINE #	6	Zo= 18	Lengh= .196	
LINE #	7	Zo= 50	Lengh= .052	
LINE #	8	Zo= 50	Lengh= .092	
LINE #	9	Zo= 12	Lengh= .196	
LINE #	10	Zo= 50	Lengh= .171	
LINE #	11	Zo= 18	Lengh= .196	
LINE #	12	Zo= 50	Lengh= .052	
LINE #	13	Zo= 50	Lengh= .092	
LINE #	14	Zo= 12	Lengh= .196	



Cktanalysis(J(\*), Fvalue, Opt) NT LIN(2);TAB(10);"Amp#2 as of 9/24/81" 'ON BASE 1 6210 COM Nogo, Zo, F, Count, SHORT Dat (51, 18) ILDATI HOLDS FREQ, CKT AND NOISE DATA 6215 DIM A(G,4),B(6,4),C(6,4),D(6,4),Y(15),W(15),L(3),Cap(3) 6220 STANDARD !#FREQS CURRENTLY STORED IN DATA BASE 6225 Count=Nogo=0 6230 Zo=50 6235 DEG IDEFAULT FOR TRIG FUNCTIONS IS DEGREES 6240 N=3 6241 Option=0 6245 Fo=15 6250 F1=14 6255 F2=16 6260 Nf=21 6265 Df=(F2-F1)/(Nf-1) 6270 DIM Fe(3,21,12) 6275 Qlam=11.8028527/(4\*Fo) 6280 INPUT "Source L1 and C1 =",L(1),Cap(1) 6285 IF N=1 THEN 6305 6290 INPUT "Source L2 and C2 =",L(2),Cap(2) 6295 IF N=2 THEN 6305 6300 INPUT "Source L3 and C3 =",L(3),Cap(3) 6305 FOR I=1 TO Nf 6310 F=F1+(I-1)\*Df FOR K=1 TO N 6315 6320 Ls=L(K) 6325 Cs=Cap(K) 6330 GOSUB Fet 6335 CALL Ntrans(A(\*),1) 6340 FOR J=1 TO 4 6345 Fe(K, I, J) = A(1, J)6350 Fe(K, I, J+4) = A(3, J)6355 Fe(K, I, J+8) = A(6, J)6360 NEXT J 6365 NEXT K 6370 NEXT 1 6375 RESTORE 6380 FOR K=1 TO 5\*N-1 6385 READ Y(K), W(K) 6390 NEXT K 6395 W5=W(5) 6400 W10=W(10) 6405 Count=0 6410 W(5)=W5-W(3)-W(7) 6415 W(10)=W10-W(8)-W(12) 6425 IF Option≈0 THEN 6435 6430 I1=INT((Nf+1)/2) 6435 FOR I=1 TO Nf 6440 IF Option=1 THEN I=I1 6445 F=F1+(I-1)\*Df 6450 FOR K=1 TO N 6455 GOSUB Circuit 6460 IF K≈H THEN 6475 6465 CALL Trline(B(\*),Y(5\*K),W(5\*K),1) 6470 CALL Cas(A(\*), B(\*)) 6475 IF K=1 THEN 6490 6480 CALL Cas(C(\*),A(\*)) 6485 GOTO 6495 6490 MAT C≃A 6495 NEXT K 6500 CALL Saveckt(C(\*),4,4,-1) 6505 CALL Nperformance(C(\*),3,50,0,50,0,G,1) 6510 IF Option=1 THEN I=Nf 6515 NEXT 1 6520 IF Option=0 THEN 6560

=10\*LGT(Dat(1,2)^2+Dat(1,3)^2) =10\*LGT(Dat(1,6)^2+Dat(1,7)^2) 6001 001=10\*LGT(Dat(1,8)^2+Dat(1,9)^2) 6535 Tem=Dat(1.14) 6540 PRINT DROUND(S11,6);DROUND(S21,6);DROUND(S22,6);DROUND(Tem,4) 6541 PRINT W(2);W(3);W(5);W(7);W(8);W(10);W(12);W(13) 6545 INPUT "?", J1, J2 6546 IF J1=0 THEN Option=0 6547 IF J1=0 THEN 6405 6548 IF J1<0 THEN Y(ABS(J1))=J2 6550 IF J1>0 THEN W(J1)=W(J1)+J2 6555 GOTO 6405 IGGGGGGGGGG 6560 GRAPHICS 6565 SCALE F1, F2, -30,0 !GHz/mm 6570 C=4/236.2 6575 D=30/162.5 !dB∕mm 6580 LINE TYPE 3 6585 AXES 1,2,Fo,-10 6590 AXES 1,10,Fo,-20 6595 LINE TYPE 5 6600 FOR K=1 TO Count PLOT Dat(K,1),10\*LGT(Dat(K,2)^2+Dat(K,3)^2) !S11 is dot-dashed 6605 6610 NEXT K 6615 PENUP 6620 LINE TYPE 3 6625 FOR K=1 TO Count PLOT Bat(K,1),(Bat(K,14)+300\*((Bat(K,8)^2+Bat(K,9)^2)/10^(Bat(K,15)/10))) 6630 /20-30 Incise is dashed 6635 NEXT K 6640 PENUP 6645 LINE TYPE 1 6650 FOR K=1 TO Count 6655 PLOT Dat(K,1),10\*LGT(Dat(K,6)^2+Dat(K,7)^2)-30 !S21 is solid 6660 NEXT K 6665 PENUP 6670 LINE TYPE 7 6675 FOR K=1 TO Count 6680 PLOT Dat(K,1),10\*LGT(Dat(K,8)^2+Dat(K,9)^2) 1822 is dble dot dash 6685 NEXT K 6690 LORG 1 6695 G=1 6700 LINE TYPE 1 6705 FOR F=F1 TO F2 STEP 2 IF F<F2 THEN 6725 6710 G=-1 6715 6720 LORG 7 6725 MOVE F+G\*C,D-30 6730 LABEL USING "K";F 6735 NEXT F 6740 LDIR 90 6745 FOR G=-20 YO 0 STEP 10 6750 MOVE F2-C.G-D 6755 LABEL USING "K";G 6760 MOVE Fo-C,G-D 6765 LABEL USING "K";20\*(G+30) 6770 NEXT G 6775 LORG 4 6780 MOVE F2-5\*C,-15 6785 LABEL USING "K";"IRG" 6790 MOVE Fo-5\*C,-15 6795 LABEL USING "K"; "NOISE" 6800 LORG 6 6805 MOVE F1+5\*C,-15 6810 LABEL USING "K"; "GAIN" 6815 LORG 9 6820 FOR G=-20 TO 0 STEP 10

VE F1+C.G-D BEL USING "K";G+30 6835 NEAF G 6840 LDIR 0 6845 FRAME 6850 PAUSE 6855 INPUT "Do you want to print this solution?",A\$ 6856 INPUT "Option =",Option 6860 IF A\$="N" THEN 6900 6865 FOR K=1 TO N 6870 PRINT "Source feedback FET #";K,"Ls=";L(K),"Cs=";Cap(K) 6875 NEXT K 6880 FOR K=1 TO 5\*N-1 6885 PRINT "LINE #";K, "Zo=";Y(K), "Lengh=";W(K) 6890 NEXT K 6895 PAUSE 6900 ! GCLEAR 6901 EXIT GRAPHICS 6902 IF Option=1 THEN 6405 6905 GOTO 6375 6910 SUBEXIT 6915 Circuit:! 6920 FOR J=1 TO 4 6925 A(1,J) = Fe(K,I,J)6930 J1=4\*(J/2-INT(J/2))-1+J  $A(2, J1) = (-1)^{J1*}A(1, J)$ 6935 6940 A(3,J) = Fe(K,I,J+4) $A(4, J1) = (-1)^{J1*A(3, J)}$ 6945 6950 A(6, J) = Fe(K, I, J+8)6955 A(5,1)=A(5,2)=1 6960 NEXT J CALL Trline(B(\*),Y(5\*K-3),W(5\*K-3),1) 6965 6970 CALL Cas(B(\*),A(\*)) CALL Trline(A(\*),Y(5\*K-2),W(5\*K-2),1) 6975 6980 CALL Cas(B(\*),A(\*)) 6985 CALL Trline(A(\*),Y(5\*K-4),W(5\*K-4),1) 6990 CALL Cas(A(\*),B(\*)) CALL Trline(B(\*),Y(5\*K-1),W(5\*K-1),1) 6995 CALL Cas(A(\*),B(\*)) 7000 7005 RETURN 01/27/82 7010 Fet:! NE-137 Model at 300K DISF "Analyzing the ckt model . . . . FREQ =";F 7015 CALL R1c(A(\*), "S",0,0,.036, "S",0) 102 7020 CALL Source(B(\*), "V", "C", 45.6, 1E7, 400.9, 1.28) lgm,R4,T 7025 CALL Par(B(\*), A(\*)) 7030 101 7035 CALL R1c(A(\*), "S",0,0,.270, "P",0) 7040 CALL Cas(A(\*),B(\*)) 103 7045 CALL R1c(B(\*), "S",0,0,.132, "P",0) 7050 CALL Cas(A(\*), B(\*)) CALL R1c(B(\*), "S", 4.4, .106,0, "P",0) 7055 !R2,L2 CALL Ser(B(\*),A(\*)) 7060 7065 CALL Ric(A(\*), "S", 6.99,.081,0, "S",0) !R1,L1 7070 CALL Cas(A(\*),B(\*)) CALL R1c(B(\*), "S", 4,.090,0, "S",0) 7075 !R3,L3 CALL Cas(A(\*),B(\*)) 7080 7085 CALL R1c(B(\*), "S",0,0,.01, "P",0) 104 !NE 13700 in [B] 7090 CALL Cas(B(\*),A(\*)) 7095 Tmin=182\*F/15 Ropt=6.64\*15/F 7100 7105 Xopt=27.33\*15/F 7110 Gn=26.5\*(F/15)^2 7115 CALL Nload(B(\*),4,Tmin,Ropt,Xopt,Gn) !Noise model CALL R1c(A(\*), "S",0,.350,0, "S",0) 7120 !Packaging L's 7125 CALL Cas(B(\*), A(\*)) 7130 CALL Cas(A(\*),B(\*)) 7131 CALL R1c(B(\*),"S",0,0,.150,"P",0) Packaging C's

```
7132
      CALL Cas(A(*),B(*))
7133
      CALL Cas(B(*),A(*))
      CALL RIC(A(*), "P",0,Ls,Cs, "P",0)
7134
7135
      CALL Ser(A(*),B(*))
       CALL Trline(B(*),120,.196,1)
7139
      CALL R1c(D(*), "P", 50, 0, 1, "P", 0)
7140
      CALL Cas(B(*),D(*))
7145
      CALL Branch(B(*), "P")
7150
7155
      CALL Cas(A(*), B(*))
      CALL Cas(B(*),A(*))
7160
7190 CHLL Trline(A(*),38,.085,1.8)
7195
      CALL Branch(A(*),"S")
7200
      CALL Cas(B(*),A(*))
      CALL Trline(A(*),38,.085,1.8)
7205
      CALL Branch(A(*), "S")
7210
7215
      CALL Cas(A(*),B(*))
7220
      DISP
7225 RETURN
7240 DATA 18,.1967
7245 DATA 50,.0530
7250
                 ! FET # 1
          50,.092
7255 DATA
7260 DATA 12,.1967
7265 DATA 50,.315
7270 DATA 18,.196
          50,.052
7275 DATA
7280
            ! FET # 2
           50,.092
7285 DATA
7290 DATA 12,.196
7295 DATA
          50,.315
7300 DATA
          18,.196
7305 DATA
           50,.052
7310
                 ! FET # 3
7315 DATA
          50,.092
7320 DATA 12..196
7325 SUBEND
```

!Output coupling C !Input coupling C !Line # 1 !Line # 2 !Line # 3 !Line # 4 !Line # 5 inter-stage !Line # 6 !Line # 7 !Line # 8 !Line # 9 !Line #10 inter-stage !Line #11 !Line #12 !Line #13 !Line #14

!Source L-C

!Bias line

-55-